

CD4011UB Types

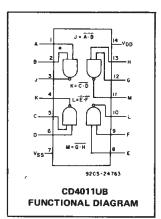
CMOS Quad 2-Input NAND Gate High-Voltage Types (20-Volt Rating)

CD4011UB guad 2-input NAND gate provides the system designer with direct implementation of the NAND function and supplements the existing family of CMOS gates.

The CD4011UB types are supplied in 14lead hermetic dual-in-line ceramic packages (D and F suffixes), 14-lead dual-inline plastic packages (E suffix), and in chip form (H suffix).

Features:

- Propagation delay time = 30 ns (typ). at $C_{L} = 50 \text{ pF}, V_{DD} = 10 \text{ V}$
- Standardized symmetrical output characteristics
- 100% tested for quiescent current at 20 V
- Maximum input current of 1 µA at 18 V over full package temperature range; 100 nA at 18 V and 25°C
- 5-V, 10-V, and 15-V parametric ratings
- Meets all requirements of JEDEC Tentative Standard No. 13B, "Standard Specifications for Description of 'B' Series CMOS Devices"



TERMINAL ASSIGNMENT

TOP VIEW CD4011UB

.1 * AR

K = CD

c

VDD — н — G

- M=GH

F

9205-24453

П - L.EF

MAXIMUM RATINGS, Absolute-Maximum Values:	
DC SUPPLY-VOLTAGE RANGE, (VDD)	
Voltages referenced to V _{SS} Terminal)	
INPUT VOLTAGE RANGE, ALL INPUTS	
DC INPUT CURRENT, ANY ONE INPUT	5
For T _A = -55°C to +100°C	
For T _A = +100°C to +125°C Derate Linearity at 12mW/°C to 200mW	
DEVICE DISSIPATION PER OUTPUT TRANSISTOR	
FOR T _A = FULL PACKAGE-TEMPERATURE RANGE (All Package Types)	۰.,
OPERATING-TEMPERATURE RANGE (TA)	
STORAGE TEMPERATURE RANGE (Tsto)	਼ੇ
LEAD TEMPERATURE (DURING SOLDERING):	
LEAD TEMPERATURE (DURING SOLDERING): At distance 1/16 ± 1/32 inch (1.59 ± 0.79mm) from case for 10s max	

RECOMMENDED OPERATING CONDITIONS

For maximum reliability, nominal operating conditions should be selected so that operation is always within the following ranges.

CHARACTERISTIC	MIN.	MAX.	UNITS
Supply Voltage Range (For TA= Full Package Tem- perature Range)	3	18	v

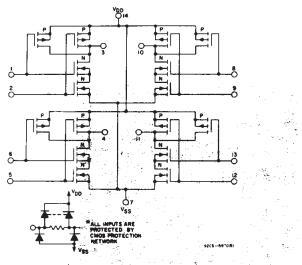
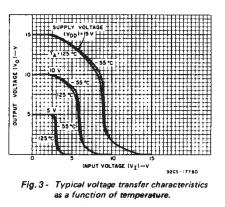


Fig. 1 - Schematic diagram for type CD4011UB.

STATIC ELECTRICAL CHARACTERISTICS

CHARACTER-	CONDITIONS			LIMITS AT INDICATED TEMPERATURES (°C)					UNITS		
ISTIC	Vo (V)	VIN (V)	VDD (V)	-55	-40	+85	+125	Min.	+25 Typ.	Max.	0.0113
Quiescent Device Current, IDD Max.	-	0,5	5	0.25	0.25	7.5	7.5		0.01	0.25	
	-	0,10	10	0.5	0.5	15	15		0.01	0.25	
	_	0,15	15	1	1	30	30		0.01	1	μA
	+	0,20	20	5	5	150	150	· _ ·	0.02	5	
Output Low	0.4	0,5	5	0.64	0.61	0.42	0.36	0.51	1		
(Sink) Current	0.5	0,10	10	1.6	1.5	1.1	0.9	1.3	2.6	-	
IOL Min.	1.5	0,15	15	4.2	4	2.8	2.4	3.4	6.8		
Output High	4.6	0,5	5	-0.64	-0.61	-0.42	-0.36	-0.51	-1	-	mΑ
(Source) Current,	2,5	0,5	5	-2	-1.8	-1.3	-1.15	-1.6	-3.2	-	
	9.5	0,10	10	-1.6	-1.5	-1.1	0.9	-1.3	-2.6	-	
IOH Min.	13.5	0,15	15	-4.2	-4	-2.8	-2.4	-3.4	-6.8	-	
Output Voltage:	-	0,5	5	0.05			-	0	0.05	1	
Low-Level,		0,10	10	0.05				-	0	0.05	
VOL Max.	·	0,15	15	0.05				0	0.05	v	
Output Voltage:		0,5	5	4.95			4.95	5	-	v	
High-Level,	-	0,10	10	9.95				9.95	10	-	
VOH Min.	-	0,15	15	14.95			14.95	15	-		
Input Low	4.5	_ ·	5	1				-	1		
Voltage,	9	-	10	2			-	-	2		
VIL Max.	13.5	_	15	2.5				-	2.5	v	
Input High	0.5,4.5	-	5			4 4 -			—	v	
Voltage,	1,9	-	10	8			8		_		
VIH Min.	1.5,13.5	-	15	12.5 12.5 -			—				
Input Current I IN Max.		0,18	18	±0.1	±0.1	±1	±1	-	±10 ⁻⁵	±0.1	μА

Fig. 2 – Minimum and maximum voltage transfer characteristics.



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COMMERCIAL CMOS HIGH VOLTAGE ICS

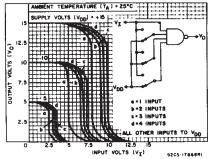
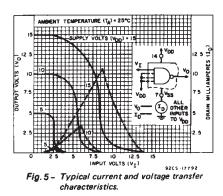


Fig. 4 – Typical multiple input switching transfer characteristics for CD4012UB.

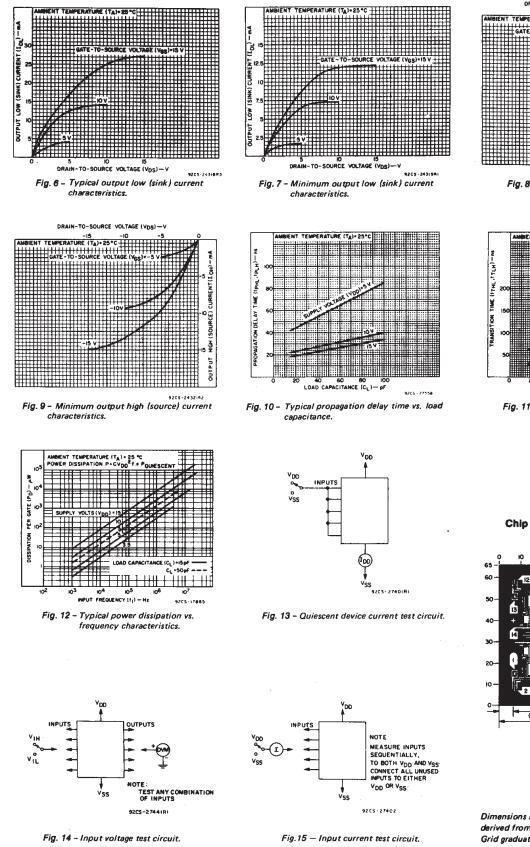


DYNAMIC ELECTRICAL CHARACTERISTICS

At $T_A = 25^{\circ}C$, Input t_r , $t_f = 20$ ns, and $C_L = 50$ pF, $R_L = 200$ k Ω

CHARACTERISTIC	TEST CONDI	LIN			
		V _{DD} VOLTS	ТҮР.	мах	UNITS
Propagation Delay Time, ^t PHL ^{, t} PLH	2.	5 10 15	60 30 25	120 60 50	ns
Transition Time, ^t THL ^{, t} TLH		5 10 15	100 50 40	200 100 80	ns
Input Capacitance, C _{IN}	Any Input		10	15	pF

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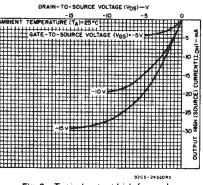


Fig. 8 - Typical output high (source) current characteristics.

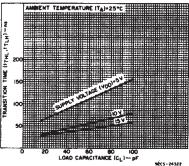
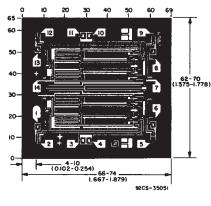


Fig. 11 - Typical transition time vs. load capacitance.





CD4011UBH

Dimensions in parentheses are in millimeters and are derived from the basic inch dimensions as indicated. Grid graduations are in mils (10^{-3} inch) .

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